Advance Information **TMOS E-FET** ™ **Power Field Effect Transistor** N-Channel Enhancement-Mode Silicon Gate

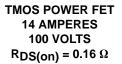
This advanced TMOS power FET is designed to withstand high energy in the avalanche and commutation modes. This new energy efficient design also offers a drain-to-source diode with a fast recovery time. Designed for low voltage, high speed switching applications in power supplies, converters, PWM motor controls, these devices are particularly well suited for bridge circuits where diode speed and commutating safe operating area are critical and offer additional safety margin against unexpected voltage transients.

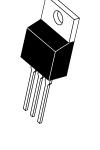
- Avalanche Energy Specified
- Source-to-Drain Diode Recovery Time Comparable to a Discrete Fast Recovery Diode
- Diode is Characterized for Use in Bridge Circuits
- IDSS and VDS(on) Specified at Elevated Temperature



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CASE 221A-09 TO-220AB

MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

Rating		Value	Unit
Drain-to-Source Voltage	VDSS	100	Vdc
Drain–to–Gate Voltage (R_{GS} = 1.0 M Ω)	VDGR	100	Vdc
Gate-to-Source Voltage — Continuous — Single Pulse (tp \leq 50 μ S)	VGS VGSM	±20 ±25	Vdc Vdc
Drain Current — Continuous — Continuous @ 100° C — Single Pulse (t _p ≤ 10 µS)	I _D I _D IDM	14 10 49	Adc Apk
Total Power Dissipation @ T _C = 25°C Derate above 25°C	PD	78 0.63	Watts W/°C
Operating and Storage Temperature Range	TJ, Tstg	-55 to 150	°C
UNCLAMPED DRAIN-TO-SOURCE AVALANCHE CHARACTERISTICS ((TJ < 150°C)	•	•
Single Pulse Drain–to–Source Avalanche Energy — STARTING T _J = 25° C (V _{DD} = 75 V, V _{GS} = 10 V, PEAK I _L = 14 A, L = 1.0 mH, R _G = 25Ω)	E _{AS}	98	mJ

THERMAL CHARACTERISTICS

Thermal Resistance — Junction-to-Case	R _{θJC}	1.60	°C/W
— Junction-to-Ambient	R _{θJA}	62.5	
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	тլ	275	°C

This document contains information on a new product. Specifications and information herein are subject to change without notice.

E-FET is a trademark of Motorola, Inc. TMOS is a registered trademark of Motorola, Inc.



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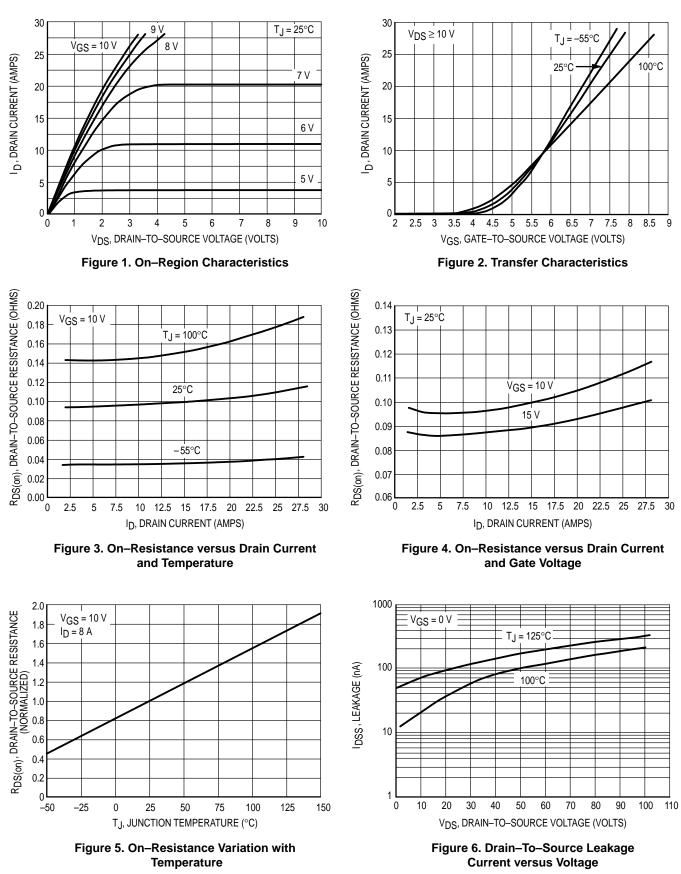
ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise noted)

Cha	racteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS		•				
		V _(BR) DSS	100	_	_	Vdc
Temperature Coefficient (Positive)		_	112	_	V/°C
Zero Gate Voltage Drain Current $(V_{DS} = 100 \text{ Vdc}, V_{GS} = 0 \text{ Vdc})$ $(V_{DS} = 100 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T$	J = 125°C)	IDSS	_	_	10 100	μAdc
Gate-Body Leakage Current ($V_{GS} = \pm 20 \text{ Vdc}, V_{DS} = 0 \text{ Vdc}$)		IGSS		_	100	nAdc
ON CHARACTERISTICS ⁽¹⁾		1				
Gate Threshold Voltage ($V_{DS} = V_{GS}$, $I_D = 0.25$ mA) Threshold Temperature Coefficien	$Cpk \geq 2.0(3)$ nt (Negative)	V _{GS(th)}	2.0	2.9 6.2	4.0	Vdc mV/°C
Static Drain-to-Source On-ResistanceCpk $\geq 2.0^{(3)}$ (V _{GS} = 10 Vdc, I _D = 8.0 Adc)		R _{DS(on)}		0.098	0.160	Ohms
$\label{eq:constraint} \begin{array}{l} \mbox{Drain-to-Source On-Voltage} \\ (V_{GS} = 10 \mbox{ Vdc}, \mbox{ I}_{D} = 14 \mbox{ Adc}) \\ (V_{GS} = 10 \mbox{ Vdc}, \mbox{ I}_{D} = 8.0 \mbox{ Adc}, \mbox{ T}_{J} \end{array}$	= 125°C)	V _{DS(on)}			2.7 2.6	Vdc
Forward Transconductance (V _{DS} =	15 Vdc, I _D = 8.0 Adc)	9FS	4.0	7.4		Mhos
DYNAMIC CHARACTERISTICS						
Input Capacitance		C _{iss}	_	700	980	pF
Output Capacitance	(V _{DS} = 25 Vdc, V _{GS} = 0 Vdc, f = 1.0 MHz)	C _{OSS}	—	200	280	
Transfer Capacitance	f = 1.0 MHz	C _{rss}	_	65	130	
SWITCHING CHARACTERISTICS		•				
Turn–On Delay Time		^t d(on)	—	9.0	20	ns
Rise Time	(V _{DS} = 50 Vdc, I _D = 14 Adc,	tr	—	58	120	
Turn–Off Delay Time	$V_{GS} = 10 \text{ Vdc}, R_G = 9.1 \Omega)$	^t d(off)	—	26	50	
Fall Time		t _f	—	33	70	
Gate Charge	(V _{DS} = 80 Vdc, I _D = 14 Adc, V _{GS} = 10 Vdc)	QT	—	26	40	nC
		Q ₁	—	5.0	_	
		Q2	_	13	_	
		Q ₃	_	11	_	
SOURCE-DRAIN DIODE CHARACT	ERISTICS					
Forward On–Voltage $(I_S = 14 \text{ Adc}, V_{GS} = 0 \text{ Vdc})$ $(I_S = 14 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_J =$	125°C)	V _{SD}		0.92 0.80	1.2	Vdc
Reverse Recovery Time	(I _S = 14 Adc, dI _S /dt = 100 A/μS)	t _{rr}	_	103	_	nS
		ta	_	78		
		t _b	_	25		
Reverse Recovery Stored Charge		Q _{RR}	—	0.46	_	μC
NTERNAL PACKAGE INDUCTANC	E	1		•		
Internal Drain Inductance (Measured from the drain lead 0.25" from package to center of die) Internal Source Inductance (Measured from screw on tab to source bond pad)		Ld	_	3.5	_	nH
		L _S		7.5		1

(2) Switching characteristics are independent of operating junction temperature.

(3) Reflects typical values.
$$Cpk = \left| \frac{Max \ limit - Typ}{3 \times sigma} \right|$$

TYPICAL ELECTRICAL CHARACTERISTICS



POWER MOSFET SWITCHING

Switching behavior is most easily modeled and predicted by recognizing that the power MOSFET is charge controlled. The lengths of various switching intervals (Δt) are determined by how fast the FET input capacitance can be charged by current from the generator.

The published capacitance data is difficult to use for calculating rise and fall because drain–gate capacitance varies greatly with applied voltage. Accordingly, gate charge data is used. In most cases, a satisfactory estimate of average input current ($I_{G(AV)}$) can be made from a rudimentary analysis of the drive circuit so that

 $t = Q/I_G(AV)$

During the rise and fall time interval when switching a resistive load, V_{GS} remains virtually constant at a level known as the plateau voltage, V_{SGP}. Therefore, rise and fall times may be approximated by the following:

 $t_r = Q_2 \times R_G/(V_{GG} - V_{GSP})$

 $t_f = Q_2 \times R_G / V_{GSP}$

where

 V_{GG} = the gate drive voltage, which varies from zero to V_{GG}

R_G = the gate drive resistance

and Q2 and VGSP are read from the gate charge curve.

During the turn-on and turn-off delay times, gate current is not constant. The simplest calculation uses appropriate values from the capacitance curves in a standard equation for voltage change in an RC network. The equations are:

 $t_{d(on)} = R_G C_{iss} ln [V_{GG}/(V_{GG} - V_{GSP})]$ $t_{d(off)} = R_G C_{iss} ln (V_{GG}/V_{GSP})$ The capacitance (C_{ISS}) is read from the capacitance curve at a voltage corresponding to the off–state condition when calculating $t_{d(on)}$ and is read at a voltage corresponding to the on–state when calculating $t_{d(off)}$.

At high switching speeds, parasitic circuit elements complicate the analysis. The inductance of the MOSFET source lead, inside the package and in the circuit wiring which is common to both the drain and gate current paths, produces a voltage at the source which reduces the gate drive current. The voltage is determined by Ldi/dt, but since di/dt is a function of drain current, the mathematical solution is complex. The MOSFET output capacitance also complicates the mathematics. And finally, MOSFETs have finite internal gate resistance which effectively adds to the resistance of the driving source, but the internal resistance is difficult to measure and, consequently, is not specified.

The resistive switching time variation versus gate resistance (Figure 9) shows how typical switching performance is affected by the parasitic circuit elements. If the parasitics were not present, the slope of the curves would maintain a value of unity regardless of the switching speed. The circuit used to obtain the data is constructed to minimize common inductance in the drain and gate circuit loops and is believed readily achievable with board mounted components. Most power electronic loads are inductive; the data in the figure is taken with a resistive load, which approximates an optimally snubbed inductive load. Power MOSFETs may be safely operated into an inductive load; however, snubbing reduces switching losses.

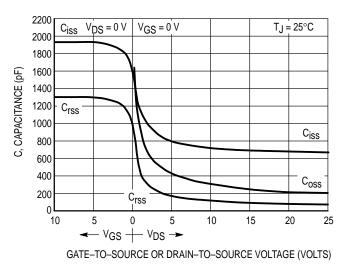


Figure 7. Capacitance Variation

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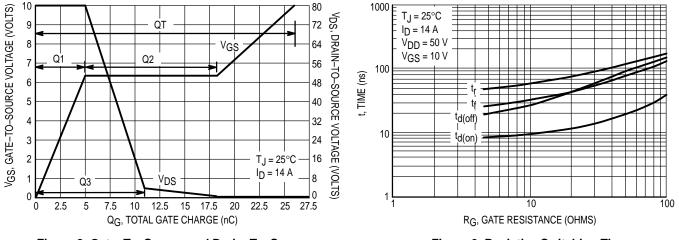


Figure 8. Gate–To–Source and Drain–To–Source Voltage versus Total Charge

Figure 9. Resistive Switching Time Variation versus Gate Resistance

DRAIN-TO-SOURCE DIODE CHARACTERISTICS

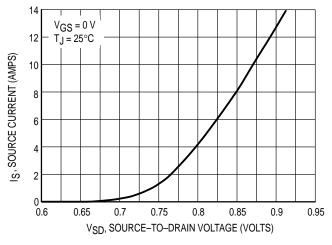


Figure 10. Diode Forward Voltage versus Current

SAFE OPERATING AREA

The Forward Biased Safe Operating Area curves define the maximum simultaneous drain-to-source voltage and drain current that a transistor can handle safely when it is forward biased. Curves are based upon maximum peak junction temperature and a case temperature (T_C) of 25°C. Peak repetitive pulsed power limits are determined by using the thermal response data in conjunction with the procedures discussed in AN569, "Transient Thermal Resistance–General Data and Its Use."

Switching between the off-state and the on-state may traverse any load line provided neither rated peak current (I_{DM}) nor rated voltage (V_{DSS}) is exceeded and the transition time (t_r,t_f) do not exceed 10 μ s. In addition the total power averaged over a complete switching cycle must not exceed (T_J(MAX) – T_C)/(R_{θJC}).

A Power MOSFET designated E-FET can be safely used in switching circuits with unclamped inductive loads. For reliable operation, the stored energy from circuit inductance dissipated in the transistor while in avalanche must be less than the rated limit and adjusted for operating conditions differing from those specified. Although industry practice is to rate in terms of energy, avalanche energy capability is not a constant. The energy rating decreases non-linearly with an increase of peak current in avalanche and peak junction temperature.

Although many E–FETs can withstand the stress of drain– to–source avalanche at currents up to rated pulsed current (I_{DM}), the energy rating is specified at rated continuous current (I_D), in accordance with industry custom. The energy rating must be derated for temperature as shown in the accompanying graph (Figure 12). Maximum energy at currents below rated continuous I_D can safely be assumed to equal the values indicated.

SAFE OPERATING AREA

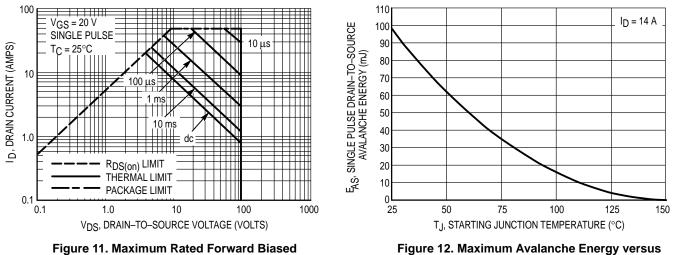




Figure 12. Maximum Avalanche Energy versus Starting Junction Temperature

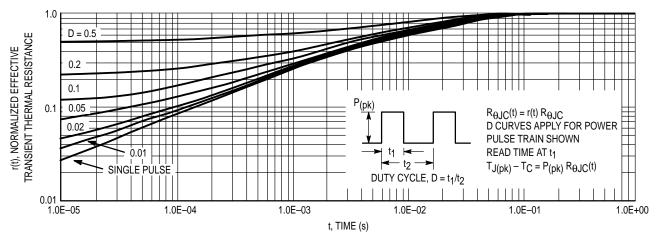


Figure 13. Thermal Response

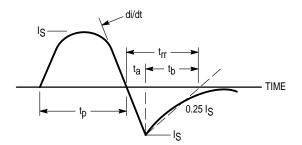
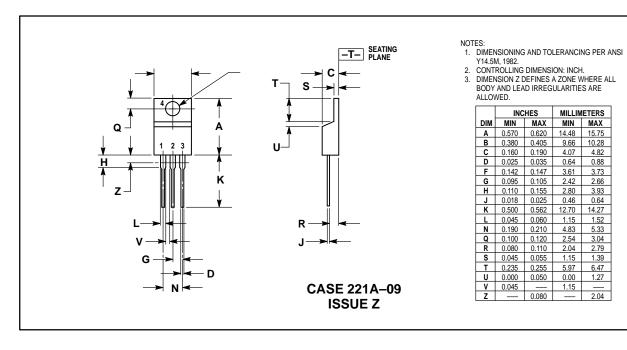


Figure 14. Diode Reverse Recovery Waveform

PACKAGE DIMENSIONS



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